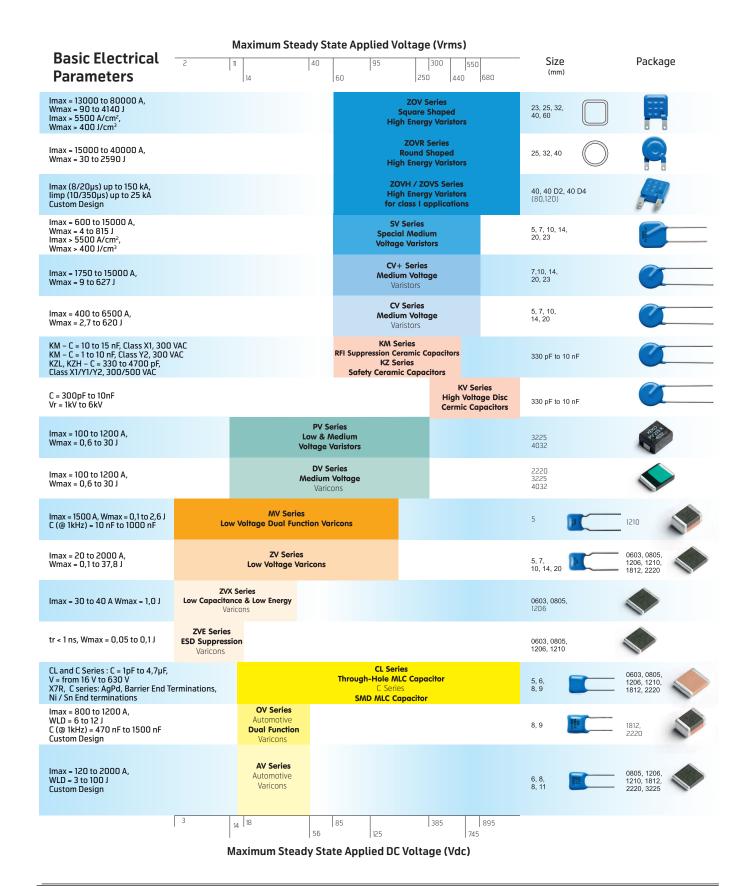
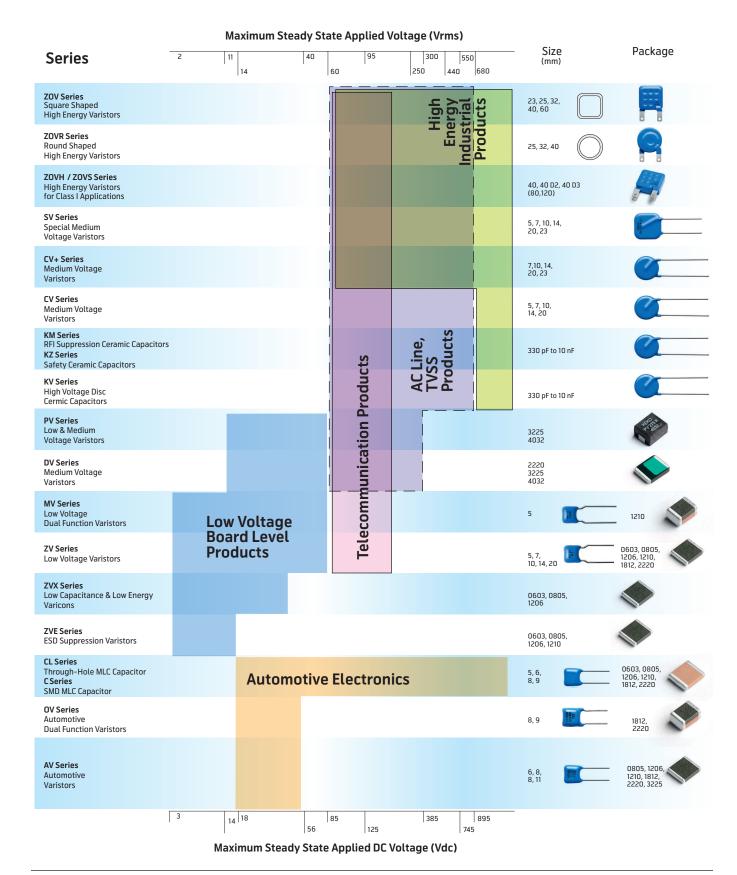
KEKOWRICON



OVERVIEW OF PROTECTIVE DEVICES



APPLICATION FIELDS



KEKO VARICON products are sold by description only – product technical specification. KEKO VARICON reserves the right to make changes in circuit design and/or specifications at any time without notice. Accordingly the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by KEKO VARICON is believed to be accurate and reliable. However, no responsibility is assumed by KEKO VARICON for its use; nor for any infringements of patents or other rights of third parties which may result from its use.

MEDIUM VOLTAGE VARISTORS - DV SERIES

Description

The DV series of medium voltage varistors is designed to protect electronic equipment against high voltage surges in the medium voltage region. They offer excellent transient energy absorption due to improved energy volume distribution and power dissipation. Compared to other medium voltage SMD varistors, DV varistors have a very low profile.

DV varistors are designed for surface mounting and are available in two model sizes – 3225 and 4032 (the 2220 size is also available upon request). These transient voltage suppressors cover an operating voltage V_{rms} from 11 to 300 V, featuring maximum surge currents from 100 A to 1200 A.



Features

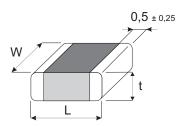
- Fully lead-free component
- Operating voltage range V_{dc}.....14 V to 385 V
- $\bullet~$ Operating voltage $V_{rms}......11\,V$ to 300 V
- 3 model sizes available2220, 3255 and 4032
- Broad range of current and energy handling capabilities
- Leadless chip form zero inductance guaranteeing the fastest response time to transient surges
- + 125 °C continuous operating temperature
- Insensitive to water cleaning procedures and to humidity corresponding to a climatic category 55/125/56
- Dimensional and weight savings on the board low profile medium voltage SMD varistor
- Non-packing improves the flammability rating
- Available in tape and reel for automatic pick and place
- **c** Tus UL 1449, 3rd edition & CSA C22.2. File E326499

Absolute Maximum Ratings

Continuous:	Units	Value
Steady State Applied Voltage:		
DC Voltage Range (V _{dc})	V	14 to 385
AC Voltage Range (V _{rms})	V	11 to 300
Transient:		
Non-Repetitive Surge Current, 8/20 µs Waveform (I _{max})	А	100 to 1200
Non-Repetitive Surge Energy, 10/1000 µs Waveform (W _{max})	J	0,6 to 30
Operating Ambient Temperature	°C	-55 to +125
Storage Temperature	°C	-55 to +150
Threshold Voltage Temperature Coefficient	%/°C	< + 0,05
Response Time	ns	< 5
Climatic Category		55 / 125 / 56



Device Ratings and Characteristics



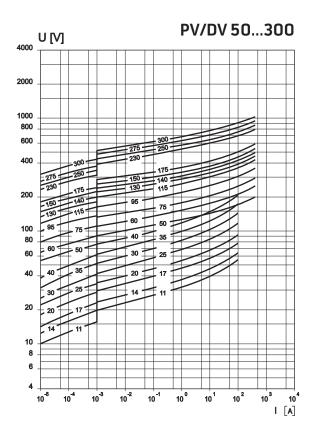
DV 11 K 3225.....DV 300 K 4032

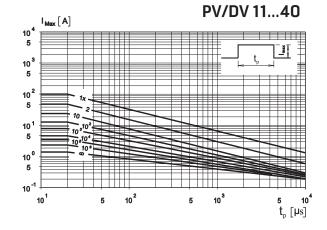
Tuno	$V_{\rm rms}$	${\rm V_{dc}}$	V _n	V _c	I _c	W_{max} 10/1000 μs	P	l _{max}	C typ.	L	W	t
Type	V	V	@ 1 mA V	V	А	Ιυ/ Ιυυυ μs J	max W	8/20 µs A	@ 1 kHz pF	±0,5 mm	±0,4 mm	max mm
DV 11 K 3225	v 11	v 14	v 18	36	2,5	0,6	0,01	100	2500	8,0	6,3	1,4
DV 11 K 4032	11	14	18	36	5	1,1	0,01	250	4300	10,0	8,0	1,4
DV 14 K 3225	14	18	22	43	2,5	0,7	0,02	100	2200	8,0	6,3	1,6
DV 14 K 3223	14	18	22	43	5	1,3	0,01	250	3500	10,0	8,0	1,6
DV 17 K 3225	17	22	27	53	2,5	0,9	0,02	100	1750	8,0	6,3	1,8
DV 17 K 4032	17	22	27	53	5	1,6	0,01	250	3000	10,0	8,0	1,8
DV 20 K 3225	20	26	33	65	2,5	1,0	0,02	100	1650	8,0	6,3	1,8
DV 20 K 4032	20	26	33	65	5	2,0	0,01	250	2300	10,0	8,0	1,8
DV 25 K 3225	25	31	39	77	2,5	1,2	0,02	100	1500	8,0	6,3	2,0
DV 25 K 4032	25	31	39	77	5	2,4	0,01	250	1900	10,0	8,0	2,0
DV 30 K 3225	30	38	47	93	2,5	1,5	0,02	100	1000	8,0	6,3	2,0
DV 30 K 4032	30	38	47	93	5	2,8	0,01	250	1600	10,0	8,0	2,0
DV 35 K 3225	35	<u> </u>	56	110	2,5	1,8	0,02	100	800	8,0	6,3	2,0
DV 35 K 4032	35	45 45	56	110	5	3,4	0,01	250	1400	10,0	8,0	2,0
DV 40 K 3225	40	56	68	135	2,5	2,2	0,02	100	700	8,0	6,3	2,0
DV 40 K 4032	40	56	68	135	5	4,1	0,01	250	1200	10,0	8,0	2,0
DV 50 K 3225	50	65	82	135	5	2,5	0,02	400	400	8,0	6,3	2,0
DV 50 K 4032	50	65	82	135	10	6,5	0,10	1200	580	10,0	8,0	2,0
DV 60 K 3225	60	85	100	165	5	3,0	0,10	400	300	8,0	6,3	2,0
DV 60 K 4032	60	85	100	165	10	7,0	0,10	1200	530	10,0	8,0	2,0
DV 75 K 3225	75	100	120	200	5	4,0	0,10	400	240	8,0	6,3	2,0
DV 75 K 4032	75	100	120	200	10	9,0	0,25	1200	480	10,0	8,0	2,0
DV 95 K 3225	95	125	150	250	5	6,0	0,10	400	210	8,0	6,3	2,0
DV 95 K 4032	95	125	150	250	10	11,0	0,25	1200	310	10,0	8,0	2,0
DV 115 K 3225	115	150	180	300	5	6,5	0,10	400	200	8,0	6,3	2,0
DV 115 K 4032	115	150	180	300	10	13,0	0,25	1200	270	10,0	8,0	2,0
DV 130 K 3225	130	170	205	340	5	7,0	0,10	400	150	8,0	6,3	2,0
DV 130 K 4032	130	170	205	340	10	15,0	0,25	1200	250	10,0	8,0	2,0
DV 140 K 3225	140	180	220	360	5	7,5	0,10	400	180	8,0	6,3	2,0
DV 140 K 4032	140	180	220	360	10	18,0	0,25	1200	240	10,0	8,0	2,0
DV 150 K 3225	150	200	240	395	5	9,0	0,10	400	150	8,0	6,3	2,0
DV 150 K 4032	150	200	240	395	10	18,5	0,25	1200	220	10,0	8,0	2,0
DV 175 K 3225	175	225	270	455	5	9,5	0,10	400	130	8,0	6,3	2,0
DV 175 K 4032	175	225	270	455	10	21,0	0,25	1200	200	10,0	8,0	2,0
DV 230 K 3225	230	300	360	595	5	10,0	0,10	400	110	8,0	6,3	2,0
DV 230 K 4032	230	300	360	595	10	23,0	0,25	1200	170	10,0	8,0	2,0
DV 250 K 3225	250	320	390	650	5	11,0	0,10	400	100	8,0	6,3	2,0
DV 250 K 4032	250	320	390	650	10	25,0	0,25	1200	160	10,0	8,0	2,0
DV 275 K 3225	275	350	430	710	5	13,0	0,10	400	90	8,0	6,3	2,0
DV 275 K 4032	275	350	430	710	10	29,0	0,25	1200	150	10,0	8,0	2,0
DV 300 K 3225	300	385	470	775	5	15,0	0,10	400	85	8,0	6,3	2,0
DV 300 K 4032	300	385	470	775	10	30,0	0,25	1200	140	10,0	8,0	2,0

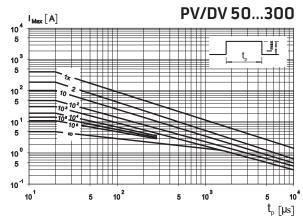
Protection Level

Pulse Rating Curves

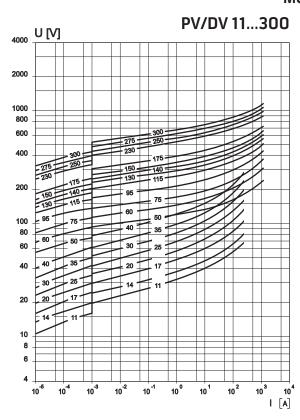
Model Size 3225

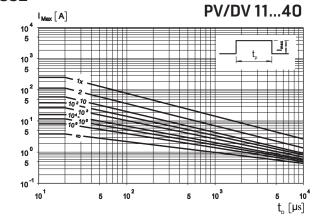


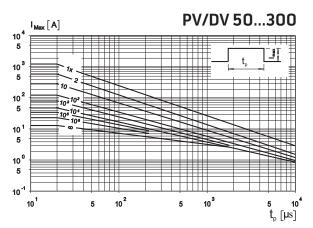




Model Size 4032

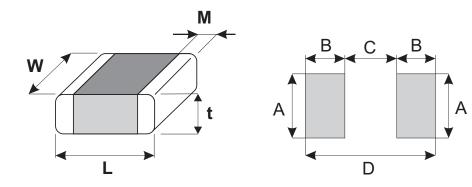






Soldering Pad Configuration

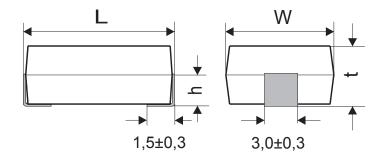
DV Series

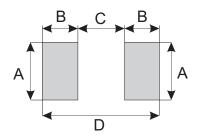


Size	Voltage range (V)	L ± 0,5 (mm)	W ± 0,4 (mm)	M ± 0,25 (mm)	t _{max} (mm)	A (mm)	B (mm)	C (mm)	D (mm)
3225	11 to 300	8,0	6,3	0,5	2,0	6,8	1,5	6,5	9,5
4032	11 to 300	10,0	8,3	0,5	2,0	6,8	1,5	8,7	11,7

^{*} size 2220 available upon request

PV Series

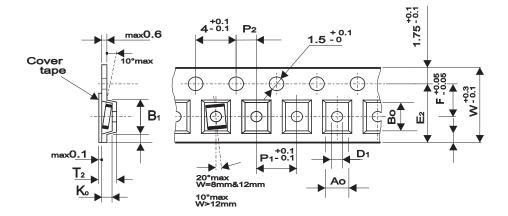




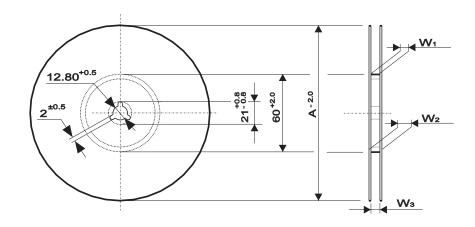
Size	Voltage range	L ± 0,5	W ± 0,4	h ± 0,3	t ± 0,3	Α	В	С	D
Size	(V)	(mm)	(mm)	(mm)	(mm)	(mm)	(mm)	(mm)	(mm)
3225	11 to 150	8,0	6,3	1,7	3,4	3,5	2,9	4,5	10,3
3225	175 to 300	8,0	6,3	2,3	4,7	3,5	2,9	4,5	10,3
4032	11 to 300	10,0	8,3	2,3	4,7	3,5	2,9	6,5	12,3

Device Ratings and Characteristics Conforms to IEC Publication 286 - 3 Ed.4: 2007-06

Tape



Reel



Variable dimensions

Tape S	Size	16	mm
Size	Units	3225	4032
Size	(mm)	7	8,6
Ao	(mm)	7,8	10,8
Во	(mm)	3,7	3,7
Ko max	(mm)	12,1	12,1
B1 max	(mm)	1,5	1,5
D1 max	(mm)	14,25	14,25
e2	(mm)	12	12
P1	(mm)	7,5	7,5
F	(mm)	16,0	16,0
W	(mm)	9,5	9,5
T2 max	(mm)	16,4+2	16,4+2
W1	(mm)	22,4	22,4
W2 max	(mm)	15,919,4	15,919,4
А	(mm)	330	330

Package units

Series	Chip Size				
Series	3225	4032			
DV	1500	1500			
PV < 175	1500	1000			
PV > 175	1000	1000			

Ordering Information PV 20 K 3225 R2 yy

PV - Series Name

20 - V_{rms}

K - V_n Tolerance: $K = \pm 10 \%$

3225 - Model Size: 3225, 4032

R2 - Packaging: R2 = Reel 330 mm

yy - Special requirements

DV 20 K 3225 N R2 yy

DV - Series Name

20 - V_{rms}

K - V_n Tolerance: $K = \pm 10 \%$

3225 - Model Size: 3225, 4032

N - Barrier type end terminations suitable for

Pb-free and Pb reflow soldering

R2 - Packaging: R2 = Reel 330 mm

yy - Special requirements

Varistor Marking for PV Series

KEKO PV 20 K 3225

KEKO - Tradename

PV - Series Name

20 - V_{rms}

K - V_n Tolerance

3225 - Model Size

ww/yy - Date code on request

SOLDERING RECOMMENDATIONS

Popular soldering techniques used for surface mounted components are Wave and Infrared Reflow processes. Both processes can be performed with Pb-containing or Pb-free solders. The termination options available for these soldering techniques are AgPd and Barrier Type End Terminations.

End termination	Designation	Recommended and Suitable for	Component RoHS Compliant
Ag/Pd	Series (ZV, AV, DV, C,) R1	Pb-containing soldering	Yes
Barrier Type End Termination	Series (ZV, AV, DV, C,) N R1	Pb-containing and Pb-free soldering	Yes
Ni Sn End Termination	Series (ZV, AV,)Ni R1	Pb-containing and Pb-free soldering v	Yes

Wave Soldering – this process is generally associated with discrete components mounted on the underside of printed circuit boards, or for large top-side components with bottom-side mounting tabs to be attached, such as the frames of transformers, relays, connectors, etc. SMD varistors to be wave soldered are first glued to the circuit board, usually with an epoxy adhesive. When all components on the PCB have been positioned and an appropriate time is allowed for adhesive curing, the completed assembly is then placed on a conveyor and run through a single, double wave process.

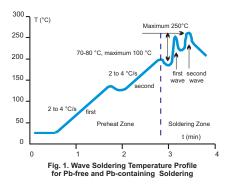
Infrared Reflow Soldering – these reflow processes are typically associated with top-side component placement. This technique utilizes a mixture of adhesive and solder compounds (and sometimes fluxes) that are blended into a paste. The paste is then screened onto PCB soldering pads specifically designed to accept a particular sized SMD component. The recommended solder paste wet layer thickness is 100 to 300 µm. Once the circuit board is fully populated with MD components, it is placed in a reflow environment, where the paste is heated to slightly above its eutectic temperature. When the solder paste reflows, the SMD components are attached to the solder pads.

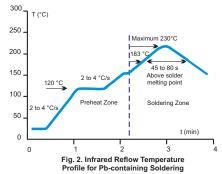
Solder Fluxes – solder fluxes are generally applied to populated circuit boards to lean oxides form forming during the heating process and to facilitate the flowing of the solder. Solder fluxes can be either a part of the solder paste compound or can be separate materials, usually fluids. Recommended fluxes are:

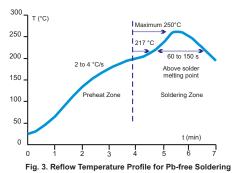
- non-activated (R) fluxes, whenever possible
- mildly activated (RMA) fluxes of class L3CN
- class ORLO

Activated (RA), water soluble or strong acidic fluxes with a chlorine content > 0.2 wt. % are NOT RECOMMENDED. The use of such fluxes could create high leakage current paths along the body of the varistor components.

When a flux is applied prior to wave soldering, it is important to completely dry any residual flux solvents prior to the soldering process.







Thermal Shock – to avoid the possibility of generating stresses in the varistor chip due to thermal shock, a preheat stage to within 100 °C of the peak soldering process temperature is recommended. Additionally, SMD varistors should not be subjected to a temperature gradient greater than 4 °C/sec., with an ideal gradient being 2 °C/sec. Peak temperatures should be controlled. Wave and Reflow soldering conditions for SMD varistors with Pb-containing solders are shown in Fig. 1 and 2 respectively, while Wave and Reflow soldering conditions for SMD varistors with Pb-free solders are shown in Fig. 1 and 3.

Whenever several different types of SMD components are being soldered, each having a specific soldering profile, the soldering profile with the least heat and the minimum amount of heating time is recommended. Once soldering has been completed, it is necessary to minimize the possibility of thermal shock by allowing the hot PCB to cool to less than 50 °C before cleaning.

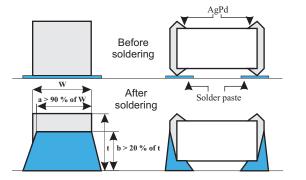
Inspection Criteria – the inspection criteria to determine acceptable solder joints, when Wave or Infrared Reflow processes are used, will depend on several key variables, principally termination material process profiles.

Pb-contining Wave and IR Reflow Soldering – typical "before" and "after" soldering results for Silver/Palladium (AgPd) and Barrier Type End Terminations can be seen in Fig. 4. Both barrier type and silver/palladium terminated varistors form a reliable electrical contact and metallurgical bond between the end terminations and the solder pads. The bond between these two metallic surfaces is exceptionally strong and has been tested by both vertical pull and lateral (horizontal) push tests. The results, in both cases, exceed established industry standards for adhesion.

The solder joint appearance of a barrier type terminated versus a sliver/palladium terminated varistor will be slightly different. Solder fo_{rms} a metallurgical junction with the thin tin-alloy (over the barrier layer), and due to its small volume "climbs" the outer surface of the terminations, the meniscus will be slightly lower. This optical appearance difference should be taken into consideration when programming visual inspection of the PCB after soldering.

Silver Palladium (AgPd) End Terminations

Barrier Type End Terminations and Ni Sn End Terminations



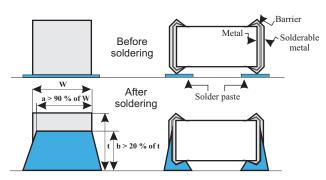
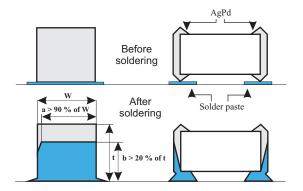


Fig. 4 Soldering Criterion in case of Wave and IR Reflow Pb-containing Soldering

Silver Palladium (AgPd) End Terminations

Barrier Type End Terminations and Ni Sn End Terminationsv



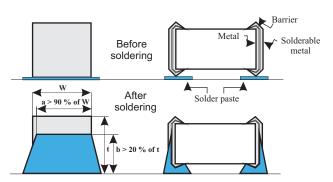


Fig. 5 Soldering Criterion in case of Wave and IR Reflow Pb-free Soldering



Pb-free Wave and IR Reflow Soldering – typical "before" and "after" soldering results for Silver/Palladium (AgPd) and Barrier Type End Terminations are given in A phenomenon knows as "mirror" or "negative" meniscus results will appear in the case of Silver/Palladium terminated varistors. Solder fo_{rms} a metallurgical junction with the entire volume of the end termination, i.e. it diffuses from pad to end termination across the inner side, forming a "mirror" or "negative meniscus. The height of the solder penetration can be clearly seen on the end termination and is always 30% higher than the chip height.

Since barrier type terminations on KEKO-VARICON chips do not require the use of problematic nickel and tin-alloy electroplating processes, these varistors are truly considered environmentally friendly.

Solder Test and Retained Samples – reflow soldering test based on J-STD-020D.1 and soldering test by dipping based on IEC 60068-2 for Pb-free solders are preformed on each production lot as shown in the following chart. Test results and accompanying samples are retained for a minimum of two (2) years. The solderability of a specific lot can be checked at any time within this period should a customer require this information.

Test	Resistance to flux	Solderability	Static leaching (simulation of Reflow Soldering)	Dynamic leaching (simunation of Wave Soldering)
Parameter				
Soldering method	dipping	dipping	dipping	dipping with agitation
Flux	L3CN, ORLO	L3CN, ORLO, R	L3CN, ORLO, R	L3CN, ORLO, R
Pb Solder	62Sn/36Pb/2Ag			
Pb Soldering tempera- ture (°C)	235 ± 5	235 ± 5	260 ± 5	235 ± 5
Pb-FREE Solder	Sn96 / Cu0,4-0,8 / 3-4Ag			
Pb-FREE Soldering temperature (°C)	250 ± 5	250 ± 5	280 ± 5	250 ± 5
Soldering time (s)	2	210	10	> 15
Burn-in conditions	V _{dcmax} , 48 h	-	-	-
Acceptance criterion	dVn < 5 %, i _{dc} must stay unchanged	> 95 % of end termina- tion must be covered by solder	> 95 % of end termination must be intact and covered by solder	> 95 % of end termination must be intact and covered by solder

Rework Criteria Soldering Iron – unless absolutely necessary, the use of soldering irons is NOT recommended for reworking varstor chips. If no other means of rework is available, the following criteria must be strictly followed:

• Do not allow the tip of the iron to directly contact the top of the chip

Do not exceed the following soldering iron specifications:
 Outp ut Power: 30 Watts maximum
 Temperature of Soldering Iron Tip: 280 °C maximum
 Soldering Time: 10 Seconds maximum

Storage Conditions – SMD varistors should be used within 1 year of purchase to avoid possible soldering problems caused by oxidized terminals. The storage environment should be controlled, with humidity less than 40% and temperature between -25 and 45 °C. Varistor chips should always be stored in their original packaged unit.

Where varistor chips have been in storage for more than 1 year, and where there is evidence of solderability difficulties, KEKO-VAR-ICON can "refresh" the terminations to eliminate these problems.

Terminology

Term	Symbol	Definition
Rated AC Voltage	V _{rms}	Maximum continuous sinusoidal AC voltage (<5% total harmonic distortion) which may be applied to the component under continuous operation conditions at 25 °C
Rated DC Voltage	V _{dc}	Maximum continuous DC voltage (<5% ripple) which may be applied to the component under continuous operating conditions at 25 $^{\circ}\text{C}$
Supply Voltage	V	The voltage by which the system is designated and to which certain operating characteristics of the system are referred; $V_{rms} = 1,1 \times V$
Leakage Current	l _{dc}	The current passing through the varistor at V_{dc} and at 25 $^{\circ}\text{C}$ or at any other specified temperature
Varistor Voltage	V _n	Voltage across the varistor measured at a given reference current In
Reference Current	In	Reference current = 1 mA DC
Clamping Voltage Protection Level	V _c	The peak voltage developed across the varistor under standard atmospheric conditions, when passing an 8/20 µs class current pulse
Class Current	I _c	A peak value of current which is 1/10 of the maximum peak current for 100 pulses at two per minute for the 8/20 µs pulse
Voltage Clamping Ratio	V _c /V _{app}	A figure of merit measure of the varistor clamping effectiveness as defined by the symbols V_c/V_{app} , where $(V_{app} = V_{rms} \text{ or } V_{dc})$
Jump Start Transient	V _{jump}	The jump start transient results from the temporary application of an overvoltage in excess of the rated battery voltage. The circuit power supply may be subjected to a temporary overvoltage condition due to the voltage regulation failing or it may be deliberately generated when it becomes necessary to boost start the car.
Rated Single Pulse Transient Energy	W _{max}	Energy which may be dissipated for a single 10/1000 µs pulse of a miaximum rated current, with rated AC voltage or rated DC voltage also applied, without causing device failure
Load Dump Transient	WLD	Load Dump is a transient which occurs in automotive environment. It is an exponentially decaying positive voltage which occurs in the event of a battery disconect while the alternator is still generating charging current with other loads remaining on the alternator circuit at the time of battery disconect.
Rated Peak Single Pulse Transient Current	I _{max}	Maximum peak current which may be applied for a single 8/20 µs pulse, with, rated line voltage also applies, without causing device failure
Rated Transient Average Power Dissipation	Р	Maximum average power which may be dissipated due to a group of pulses occurring within a specified isolated time period, without causing device failure at 25 °C
Capacitance	С	Capacitance between two terminals of the varistor measured at @ 1 kHz
Non-linearity Exponent	α	A measure of varistor nonlinearity between two given operating currents, I_n and I_1 , as described by $I=k$ V exp(a), where: - k is a device constant, - $I_1 < I < i_n$ and - a 0 log (I_1/I_n)/log(V_1/V_n) = 1/log(V1/ V_n), where: - I_n is reference current (1 mA) and V_n is varistor voltage - $I_1 = 10$ In, V_1 is the voltage measured at I_1
Response Time	tr	The time lag between application of a surge and varistor's "turn-on" conduction action
Varistor Voltage Temperature Coefficient	TC	$(V_n \text{ at } 85 ^{\circ}\text{C} - V_n \text{ at } 25 ^{\circ}\text{C}) / (V_n \text{ at } 25 ^{\circ}\text{C}) \times 60 ^{\circ}\text{C}) \times 100$
Insulation Resistance	IR	Minimum resistance between shorted terminals and varistor surface
Isolation Voltage		The maximum peak voltage which may be applied under continuous operating conditions between the varistro terminations and any conducting mounting surface
Operating Temperature		the range of ambient temperature for which the varistor is designed to operate continuously as defined by the temperature limits of its climatic category
Climatic Category	LCT/UCT/ DHD	UCT = Upper Category Temperature - the maximum ambient temperature for which a varistor has been designed to operate continuously, LCT = Lower Category Temperature - the minimum ambient temperature at which a varistor has been designed to operate continuously DHD = Dump Heat Test Duration
Storage Temperature		Storage temperature range without voltage applied
Current/Energy Derating		Derating of maximum values when operated above UCT (85 °C for PV and 125 °C for DV)

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